

RICOH

LOW VOLTAGE DETECTOR R3111xxx1A/C Series

■ OUTLINE

The R3111 Series are voltage detector ICs with high detector threshold accuracy and ultra-low supply current by CMOS process, which can be operated at an extremely low voltage and is used for system reset as an example. Each of these ICs consists of a voltage reference unit, a comparator, resistors for detector threshold setting, an output driver and a hysteresis circuit. The detector threshold is fixed with high accuracy internally and does not require any adjustment. Two output types, Nch open drain type and CMOS type are available. The R3111 Series are operable at a lower voltage than that for the RX5VL Series, and can be driven by a single battery. Four types of packages, TO-92, SOT-89, SOT-23-5 and SC-82AB are available.

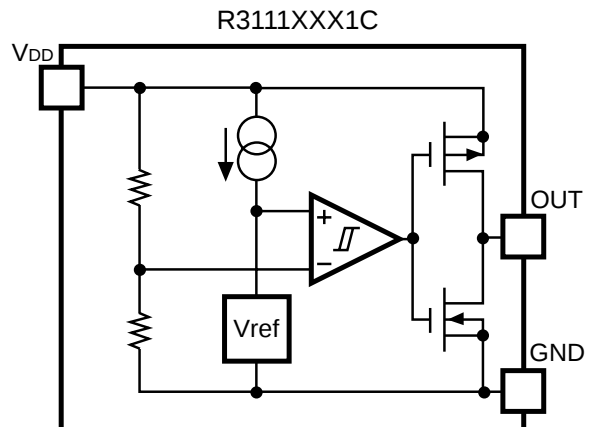
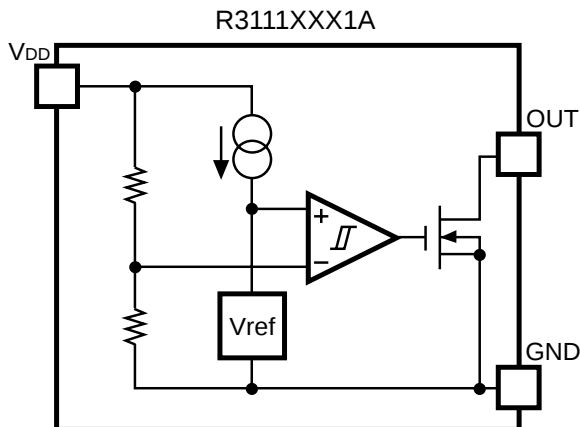
■ FEATURES

- Ultra-low Supply Current..... TYP. 0.8 μ A ($V_{DD}=1.5V$)
- Wide Range of Operating Voltage..... 0.7 to 10.0V($T_{opt}=25^{\circ}C$)
- Detector Threshold..... Stepwise setting with a step of 0.1V in the range of 0.9V to 6.0V is possible.
- High Accuracy Detector Threshold..... $\pm 2.0\%$
- Low Temperature-Drift Coefficient of Detector Threshold..... TYP. $\pm 100ppm/^{\circ}C$
- Two Output Types..... Nch Open Drain and CMOS
- Four Types of Packages..... TO-92, SOT-89(Mini-power Mold), SOT-23-5 (Mini-mold), SC-82AB

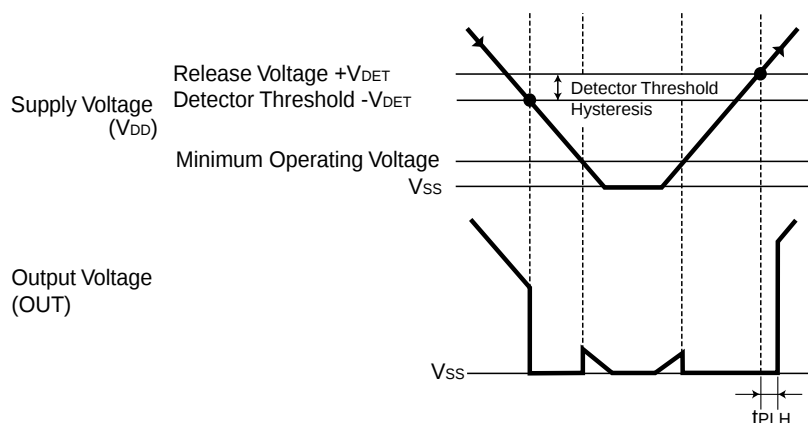
■ APPLICATIONS

- CPU and Logic Circuit Reset
- Battery Checker
- Window Comparator
- Wave Shaping Circuit
- Battery Back-up Circuit
- Power Failure Detector

■ BLOCK DIAGRAMS



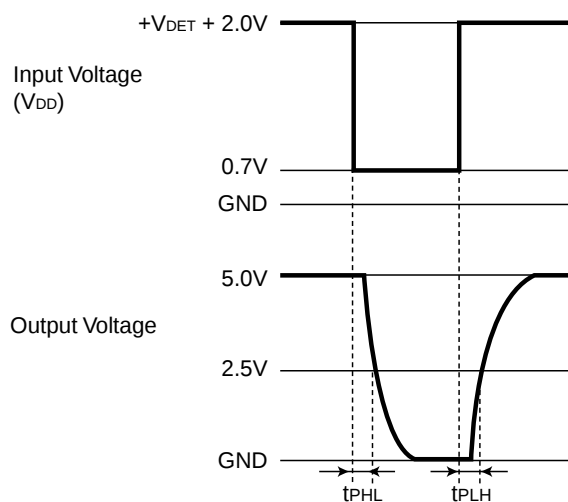
■ TIMING CHART



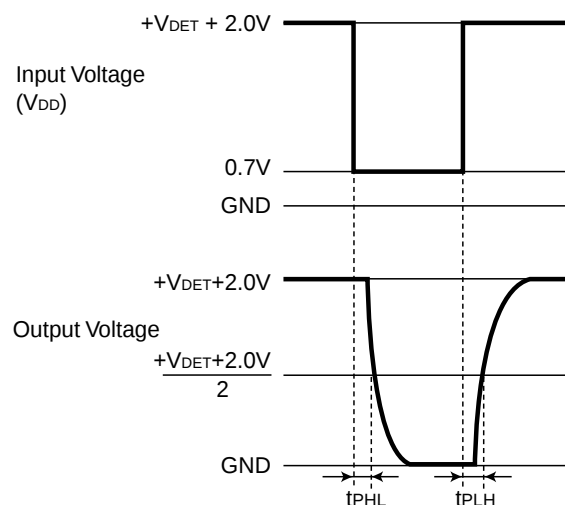
■ DEFINITION OF OUTPUT DELAY TIME

Output Delay Time t_{PLH} is defined as follows:

1. In the case of Nch Open Drain Output:
Under the condition of the output pin (OUT) is pulled up through a resistor of 470k Ω to 5V, the time interval between the rising edge of V_{DD} pulse from 0.7V to $(+V_{DET}) + 2.0V$ and becoming of the output voltage to 2.5V.
2. In the case of CMOS Output:
The time interval between the rising edge of V_{DD} pulse from 0.7V to $(+V_{DET}) + 2.0V$ and becoming of the output voltage to $(V_{DD}/2)$ V.



Nch Open Drain Output



CMOS Output

■ SELECTION GUIDE

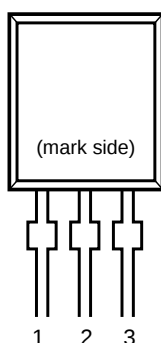
The package type, the detector threshold, the output type and the taping type of R3111 Series can be designated at the users' request by specifying the part number as follows;

R3111×××1×-×× ←Part Number
 ↑↑ ↑↑
 a b c d

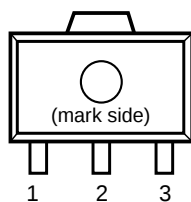
Code	Contents
a	Designation of Package Type; E: TO-92 Q: SC-82AB H: SOT-89 N: SOT-23-5
b	Setting Detector Threshold ($-V_{DET}$); Stepwise setting with a step of 0.1V in the range of 0.9V to 6.0V is possible.
c	Designation of Output Type; A: Nch Open Drain C: CMOS
d	Designation of Packing or Taping Type ; Ex.TO-92: TZ, SOT-89: T1, SOT-23-5, SC-82AB: TR are prescribed as standard directions. (Refer to Taping Specifications.) Antistatic bag for samples: C

■ PIN CONFIGURATION

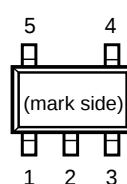
● TO-92



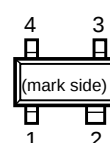
● SOT-89



● SOT-23-5



● SC-82AB



■ PIN DESCRIPTION

● TO-92

Pin No.	Symbol
1	V _{DD}
2	GND
3	OUT

● SOT-89

Pin No.	Symbol
1	OUT
2	V _{DD}
3	GND

● SOT-23-5

Pin No.	Symbol
1	OUT
2	V _{DD}
3	GND
4	NC
5	NC

● SC-2AB

Pin No.	Symbol
1	OUT
2	V _{DD}
3	NC
4	GND

■ ABSOLUTE MAXIMUM RATINGS

Symbol	Item	Rating	Unit
V _{DD}	Supply Voltage	12	V
V _{OUT1}	Output Voltage (CMOS)	V _{SS} -0.3 to V _{DD} +0.3	V
V _{OUT2}	Output Voltage (Nch)	V _{SS} -0.3 to 12	V
I _{OUT}	Output Current	70	mA
P _D	Power Dissipation 1* ^{Note1}	300	mW
P _D	Power Dissipation 2* ^{Note2}	150	mW
T _{opt}	Operating Temperature Range	-40 to 85	°C
T _{stg}	Storage Temperature Range	-55 to 125	°C
T _{solder}	Lead temperature (Soldering)	260°C, 10s	

*Note 1: applied to SOT-89 and TO-92

*Note 2: applied to SOT-23-5 and SC-82AB

■ ELECTRICAL CHARACTERISTICS

● R3111x091A/C

Topt=25°C

Symbol	Item	Conditions	MIN.	TYP.	MAX.	Unit
$-V_{DET}$	Detector Threshold		0.882	0.900	0.918	V
V_{HYS}	Detector Threshold Hysteresis		0.027	0.045	0.063	V
I_{SS}	Supply Current	$V_{DD}=0.80V$ 2.90V		0.8 0.9	2.4 2.7	μA
V_{DDH}	Maximum Operating Voltage				10	V
V_{DDL}	Minimum Operating Voltage*Note1	Topt=25°C		0.55	0.70	V
		-40°C≤Topt≤85°C		0.65	0.80	
I_{OUT}	Output Current (Driver Output Pin)	Nch $V_{DS}=0.05V, V_{DD}=0.70V$	0.01	0.05		mA
		$V_{DS}=0.50V, V_{DD}=0.85V$	0.05	0.50		
		Pch $V_{DS}=-2.1V, V_{DD}=4.5V$	1.0	2.0		mA
t_{PLH}	Output Delay Time*Note2				100	μs
$\Delta V_{DET}/\Delta T$	Detector Threshold Temperature Coefficient	-40°C≤Topt≤85°C		±100		ppm/°C

● R3111x181A/C

Topt=25°C

Symbol	Item	Conditions	MIN.	TYP.	MAX.	Unit
$-V_{DET}$	Detector Threshold		1.764	1.800	1.836	V
V_{HYS}	Detector Threshold Hysteresis		0.054	0.090	0.126	V
I_{SS}	Supply Current	$V_{DD}=1.70V$ 3.80V		0.8 1.0	2.4 3.0	μA
V_{DDH}	Maximum Operating Voltage				10	V
V_{DDL}	Minimum Operating Voltage*Note1	Topt=25°C		0.55	0.70	V
		-40°C≤Topt≤85°C		0.65	0.80	
I_{OUT}	Output Current (Driver Output Pin)	Nch $V_{DS}=0.05V, V_{DD}=0.70V$	0.01	0.05		mA
		$V_{DS}=0.50V, V_{DD}=0.85V$	1.00	2.00		
		Pch $V_{DS}=-2.1V, V_{DD}=4.5V$	1.0	2.0		mA
t_{PLH}	Output Delay Time*Note2				100	μs
$\Delta V_{DET}/\Delta T$	Detector Threshold Temperature Coefficient	-40°C≤Topt≤85°C		±100		ppm/°C

● R3111x271A/C T_{opt}=25°C

Symbol	Item	Conditions	MIN.	TYP.	MAX.	Unit
-V _{DET}	Detector Threshold		2.646	2.700	2.754	V
V _{HYS}	Detector Threshold Hysteresis		0.081	0.135	0.189	V
I _{SS}	Supply Current	V _{DD} =2.60V 4.70V		0.9 1.1	2.7 3.3	μA
V _{DDH}	Maximum Operating Voltage				10	V
V _{DDL}	Minimum Operating Voltage* ^{Note1}	T _{opt} =25°C		0.55	0.70	V
		-40°C≤T _{opt} ≤85°C		0.65	0.80	
I _{OUT}	Output Current (Driver Output Pin)	Nch V _{DS} =0.05V, V _{DD} =0.70V V _{DS} =0.50V, V _{DD} =1.50V	0.01 1.00	0.05 2.00		mA
		Pch V _{DS} =-2.1V, V _{DD} =4.5V	1.0	2.0		
t _{PLH}	Output Delay Time* ^{Note2}				100	μs
Δ-V _{DET} /ΔT	Detector Threshold Temperature Coefficient	-40°C≤T _{opt} ≤85°C		±100		ppm/°C

● R3111x361A/C T_{opt}=25°C

Symbol	Item	Conditions	MIN.	TYP.	MAX.	Unit
-V _{DET}	Detector Threshold		3.528	3.600	3.672	V
V _{HYS}	Detector Threshold Hysteresis		0.108	0.180	0.252	V
I _{SS}	Supply Current	V _{DD} =3.47V 5.60V		1.0 1.2	3.0 3.6	μA
V _{DDH}	Maximum Operating Voltage				10	V
V _{DDL}	Minimum Operating Voltage* ^{Note1}	T _{opt} =25°C		0.55	0.70	V
		-40°C≤T _{opt} ≤85°C		0.65	0.80	
I _{OUT}	Output Current (Driver Output Pin)	Nch V _{DS} =0.05V, V _{DD} =0.70V V _{DS} =0.50V, V _{DD} =1.50V	0.01 1.00	0.05 2.00		mA
		Pch V _{DS} =-2.1V, V _{DD} =4.5V	1.0	2.0		
t _{PLH}	Output Delay Time* ^{Note2}				100	μs
Δ-V _{DET} /ΔT	Detector Threshold Temperature Coefficient	-40°C≤T _{opt} ≤85°C		±100		ppm/°C

● R3111x451A/C

Topt=25°C

Symbol	Item	Conditions	MIN.	TYP.	MAX.	Unit
$-V_{DET}$	Detector Threshold		4.410	4.500	4.590	V
V_{HYS}	Detector Threshold Hysteresis		0.135	0.225	0.315	V
I_{SS}	Supply Current	$V_{DD}=4.34V$ 6.50V		1.1 1.3	3.3 3.9	μA
V_{DDH}	Maximum Operating Voltage				10	V
V_{DDL}	Minimum Operating Voltage* ^{Note1}	Topt=25°C		0.55	0.70	V
		-40°C≤Topt≤85°C		0.65	0.80	
I_{OUT}	Output Current (Driver Output Pin)	Nch $V_{DS}=0.05V, V_{DD}=0.70V$ $V_{DS}=0.50V, V_{DD}=1.50V$	0.01 1.00	0.05 2.00		mA
		Pch $V_{DS}=-2.1V, V_{DD}=8.0V$	1.5	3.0		
t_{PLH}	Output Delay Time* ^{Note2}				100	μs
$\Delta V_{DET}/\Delta T$	Detector Threshold Temperature Coefficient	-40°C≤Topt≤85°C		±100		ppm/°C

● R3111x541A/C

Topt=25°C

Symbol	Item	Conditions	MIN.	TYP.	MAX.	Unit
$-V_{DET}$	Detector Threshold		5.292	5.400	5.508	V
V_{HYS}	Detector Threshold Hysteresis		0.162	0.270	0.378	V
I_{SS}	Supply Current	$V_{DD}=5.20V$ 7.40V		1.2 1.4	3.6 4.2	μA
V_{DDH}	Maximum Operating Voltage				10	V
V_{DDL}	Minimum Operating Voltage* ^{Note1}	Topt=25°C		0.55	0.70	V
		-40°C≤Topt≤85°C		0.65	0.80	
I_{OUT}	Output Current (Driver Output Pin)	Nch $V_{DS}=0.05V, V_{DD}=0.70V$ $V_{DS}=0.50V, V_{DD}=1.50V$	0.01 1.00	0.05 2.00		mA
		Pch $V_{DS}=-2.1V, V_{DD}=8.0V$	1.5	3.0		
t_{PLH}	Output Delay Time* ^{Note2}				100	μs
$\Delta V_{DET}/\Delta T$	Detector Threshold Temperature Coefficient	-40°C≤Topt≤85°C		±100		ppm/°C

*Note1: Minimum Operating Voltage means the value of input voltage when output voltage maintains 0.1V or less.
(In the case of Nch Open Drain Type, Output pin is pulled up with a resistance of 470kΩ to 5.0V.)

*Note2: In the case of CMOS Output Type: The time interval between the rising edge of V_{DD} input pulse from 0.7V to $(+V_{DET})+2.0V$ and output voltage level becoming to $V_{DD}/2$.

In the case of Nch Open Drain Output Type: Output pin is pulled up with a resistance of 470kΩ to 5.0V, The time interval between the rising edge of V_{DD} input pulse from 0.7V to $(+V_{DET})+2.0V$ and output voltage level becoming to 2.5V.

ELECTRICAL CHARACTERISRICS BY DETECTOR THRESHOLD

R3111x09x to R3111x60x

Part Number	Detector Threshold			Detector Threshold Hysteresis			Supply Current 1			Supply Current 2		
	-V _{DET} [V]			V _{HYS} [V]			I _{SS1} [μA]			I _{SS2} [μA]		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	Condition	TYP.	MAX.	Condition	TYP.	MAX.
R3111x091x	0.882	0.900	0.918	0.027	0.045	0.063	V _{DD} = (-V _{DET}) -0.10V	0.8	2.4	V _{DD} = (-V _{DET}) +2.0V	0.9	2.7
R3111x101x	0.980	1.000	1.020	0.030	0.050	0.070					1.0	3.0
R3111x111x	1.078	1.100	1.122	0.033	0.055	0.077						
R3111x121x	1.176	1.200	1.224	0.036	0.060	0.084						
R3111x131x	1.274	1.300	1.326	0.039	0.065	0.091						
R3111x141x	1.372	1.400	1.428	0.042	0.070	0.098						
R3111x151x	1.470	1.500	1.530	0.045	0.075	0.105						
R3111x161x	1.568	1.600	1.632	0.048	0.080	0.112						
R3111x171x	1.666	1.700	1.734	0.051	0.085	0.119						
R3111x181x	1.764	1.800	1.836	0.054	0.090	0.126						
R3111x191x	1.862	1.900	1.938	0.057	0.095	0.133						
R3111x201x	1.960	2.000	2.040	0.060	0.100	0.140						
R3111x211x	2.058	2.100	2.142	0.063	0.105	0.147						
R3111x221x	2.156	2.200	2.244	0.066	0.110	0.154						
R3111x231x	2.254	2.300	2.346	0.069	0.115	0.161						
R3111x241x	2.352	2.400	2.448	0.072	0.120	0.168						
R3111x251x	2.450	2.500	2.550	0.075	0.125	0.175						
R3111x261x	2.548	2.600	2.652	0.078	0.130	0.182						
R3111x271x	2.646	2.700	2.754	0.081	0.135	0.189						
R3111x281x	2.744	2.800	2.856	0.084	0.140	0.196						
R3111x291x	2.842	2.900	2.958	0.087	0.145	0.203						
R3111x301x	2.940	3.000	3.060	0.090	0.150	0.210						
R3111x311x	3.038	3.100	3.162	0.093	0.155	0.217						
R3111x321x	3.136	3.200	3.264	0.096	0.160	0.224						
R3111x331x	3.234	3.300	3.366	0.099	0.165	0.231						
R3111x341x	3.332	3.400	3.468	0.102	0.170	0.238						
R3111x351x	3.430	3.500	3.570	0.105	0.175	0.245						
R3111x361x	3.528	3.600	3.672	0.108	0.180	0.252						
R3111x371x	3.626	3.700	3.774	0.111	0.185	0.259						
R3111x381x	3.724	3.800	3.876	0.114	0.190	0.266						
R3111x391x	3.822	3.900	3.978	0.117	0.195	0.273						
R3111x401x	3.920	4.000	4.080	0.120	0.200	0.280						
R3111x411x	4.018	4.100	4.182	0.123	0.205	0.287						
R3111x421x	4.116	4.200	4.284	0.126	0.210	0.294						
R3111x431x	4.214	4.300	4.386	0.129	0.215	0.301						
R3111x441x	4.312	4.400	4.488	0.132	0.220	0.308						
R3111x451x	4.410	4.500	4.590	0.135	0.225	0.315						
R3111x461x	4.508	4.600	4.692	0.138	0.230	0.322						
R3111x471x	4.606	4.700	4.794	0.141	0.235	0.329						
R3111x481x	4.704	4.800	4.896	0.144	0.240	0.336						
R3111x491x	4.802	4.900	4.998	0.147	0.245	0.343						
R3111x501x	4.900	5.000	5.100	0.150	0.250	0.350						
R3111x511x	4.998	5.100	5.202	0.153	0.255	0.357						
R3111x521x	5.096	5.200	5.304	0.156	0.260	0.364						
R3111x531x	5.194	5.300	5.406	0.159	0.265	0.371						
R3111x541x	5.292	5.400	5.508	0.162	0.270	0.378						
R3111x551x	5.390	5.500	5.610	0.165	0.275	0.385						
R3111x561x	5.488	5.600	5.712	0.168	0.280	0.392						
R3111x571x	5.586	5.700	5.814	0.171	0.285	0.399						
R3111x581x	5.684	5.800	5.916	0.174	0.290	0.406						
R3111x591x	5.782	5.900	6.018	0.177	0.295	0.413						
R3111x601x	5.880	6.000	6.120	0.180	0.300	0.420						

Note 1: In the case of CMOS Output parts; when the voltage is forced to V_{DD} from 0.7V to (+V_{DET})+2.0V, time interval between the rising edge of V_{DD} and the reaching point at 50% of Output Voltage. In the case of Nch open Drain Output parts : Output pin is pulled up to 5V through 470kΩ, and when the voltage is forced to V_{DD} from 0.7V to (+V_{DET})+2.0V, time interval between the rising edge of V_{DD} and the reaching point at 50% of Output Voltage.

Note 2: V_{DD} value when Output Voltage is equal or less than 0.1V. In the case of Nch Open Drain Output parts, Output pin is pulled up to 5V through 470kΩ resistor.

Condition 1: T_{opt}=25°C

Condition 2: -40°C≤T_{opt}≤85°C

Output Current 1			Output Current 2				Output Delay Time	Minimum Operating Voltage		Detector Threshold Temperature Coefficient	
I _{OUT1} [mA]			I _{OUT2} [mA]				t _{PLH} [μs]	V _{DDL} [V]		ΔV _{DET} /ΔT[ppm/°C]	
Condition	MIN.	TYP.	Condition		MIN.	TYP.	MAX.	TYP.	MAX.	Condition	TYP.
Nch V _{DS} =0.05V V _{DD} =0.7V	0.01	0.05	Nch V _{DS} =0.5V	V _{DD} =0.85V	0.05	0.5	Note 1 100	Note 2 Condition 1 0.55 Condition 2 0.65	Note 2 Condition 1 0.70 Condition 2 0.80	-40°C≤ T _{opt} ≤85°C	±100
				V _{DD} =1.0V	0.2	1.0					
				V _{DD} =1.5V	1.0	2.0					

■ OPERATION

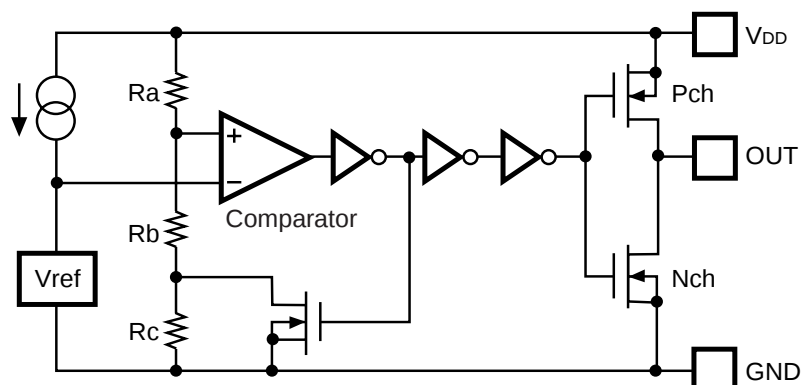


Figure 1. Block Diagram

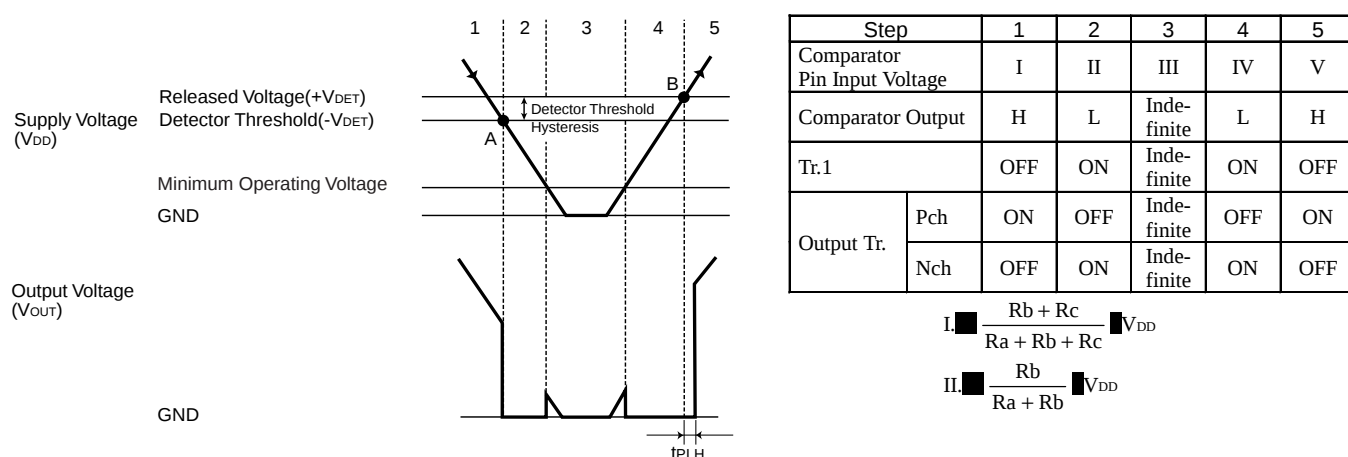


Figure 2. Operation Diagram

- Step 1. Output Voltage is equal to Supply Voltage (V_{DD}).
 - Step 2. At Point "A", $V_{ref} \geq V_{DD} \times (R_b + R_c) / (R_a + R_b + R_c)$ is true, as a result, the output of comparator is reverse, and output voltage becomes to GND level. The voltage level of Point A means detector threshold voltage, or ($-V_{DET}$).
 - Step 3. When the supply voltage is less than minimum operating voltage, the operation of output transistor becomes indefinite, and in the case that output is pulled up to V_{DD} , Output voltage equals to V_{DD} voltage.
 - Step 4. Output Voltage equals to GND level.
 - Step 5. At Point "B", $V_{ref} \leq V_{DD} \times R_b / (R_a + R_b)$ is true, Output of the comparator is reverse, and output voltage is equal to the supply voltage, or (V_{DD}). The voltage level of Point B means released voltage, or ($+V_{DET}$).
- * The difference between Released Voltage and Detector Threshold Voltage is Detector Threshold Hysteresis.

TEST CIRCUITS

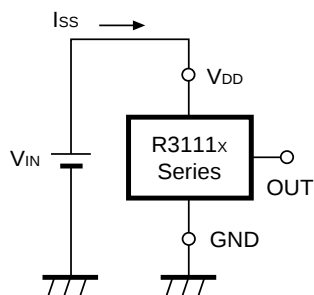
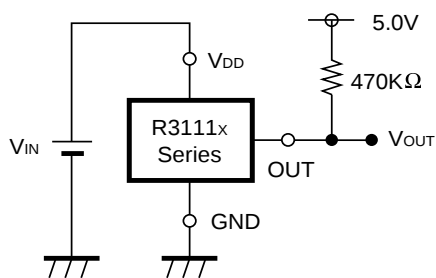


Figure 3. Supply Current Test Circuit



*Pull-up circuit is not necessary for CMOS Output type, or R3111XXXXC.

Figure 4. Detector Threshold Test Circuit

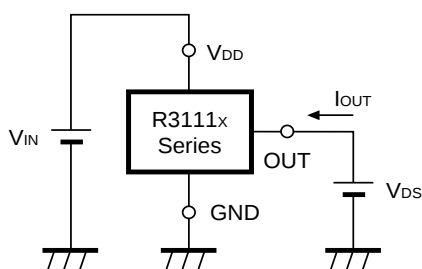
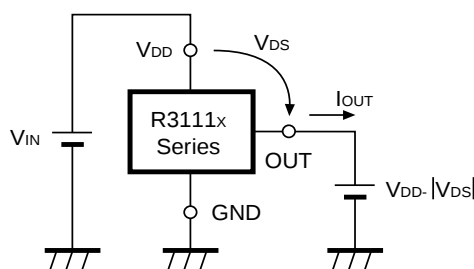


Figure 5. Nch Driver Output Current Test Circuit



*Apply only to CMOS

Figure 6. Pch Driver Output Current Test Circuit

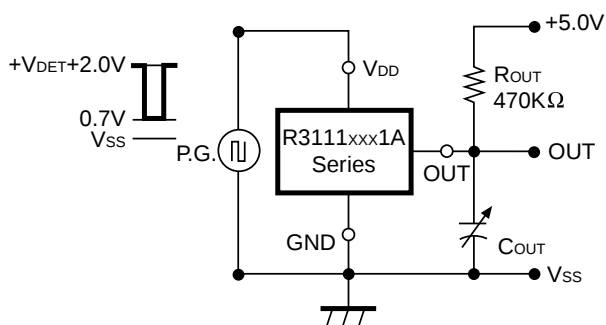


Figure 7. Output Delay Time Test Circuit (1)

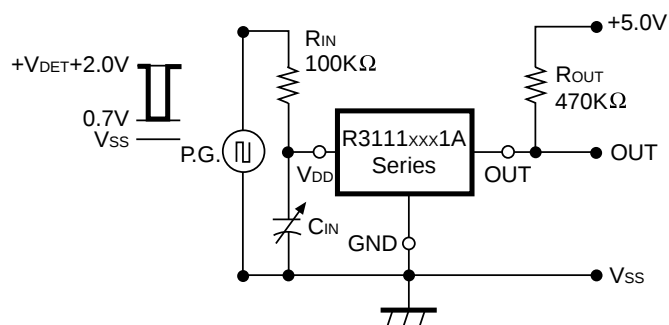
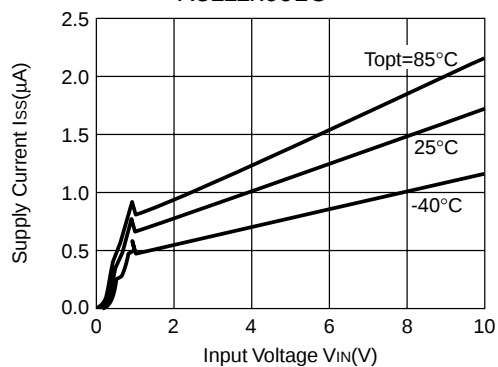


Figure 8. Output Delay Time Test Circuit (2)

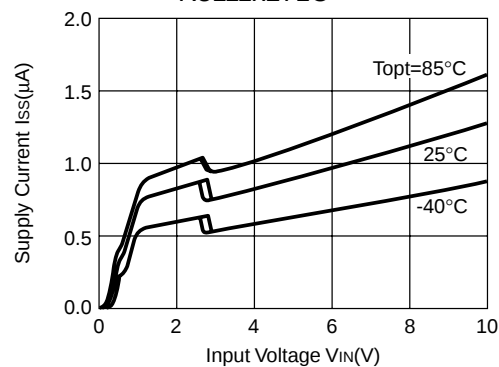
■ TYPICAL CHARACTERISTICS

1) Supply Current vs. Input Voltage

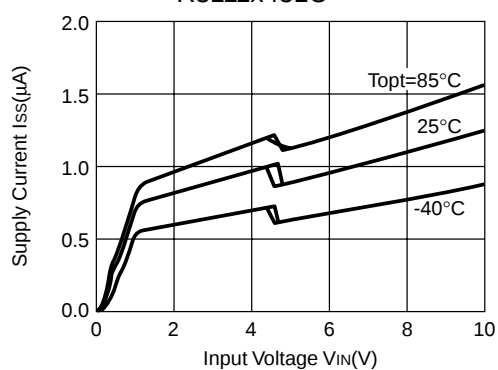
R3111x091C



R3111x271C

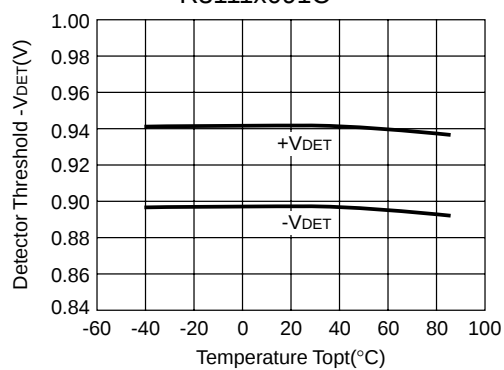


R3111x451C

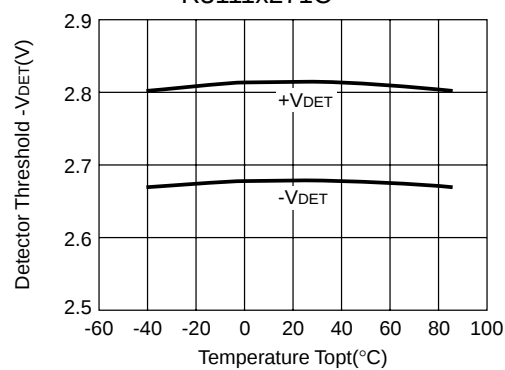


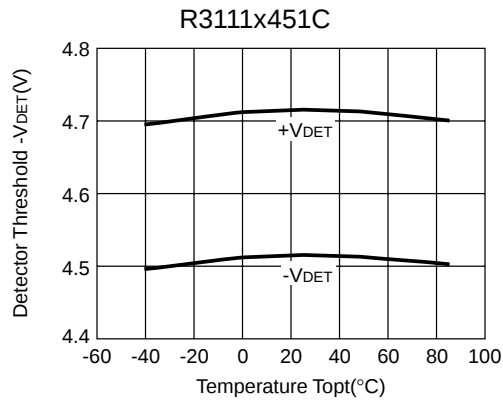
2) Detector Threshold Hysteresis vs. Temperature

R3111x091C

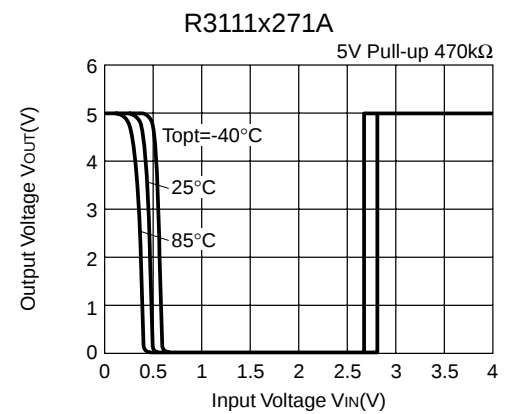
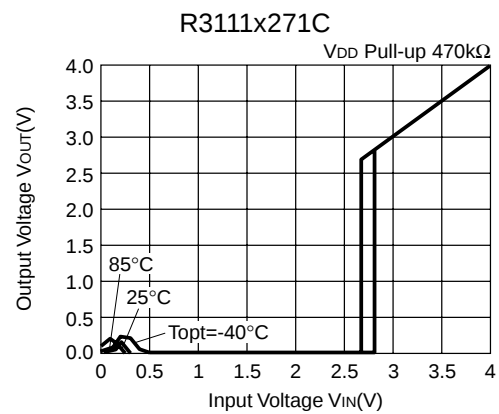
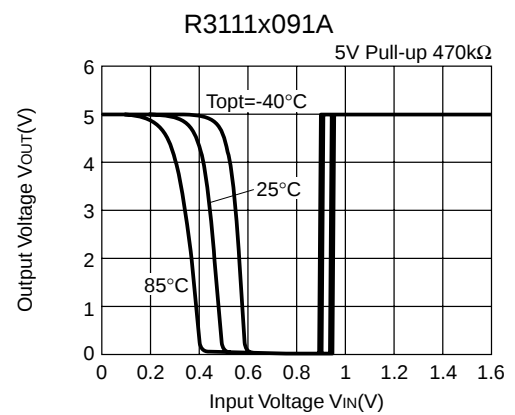
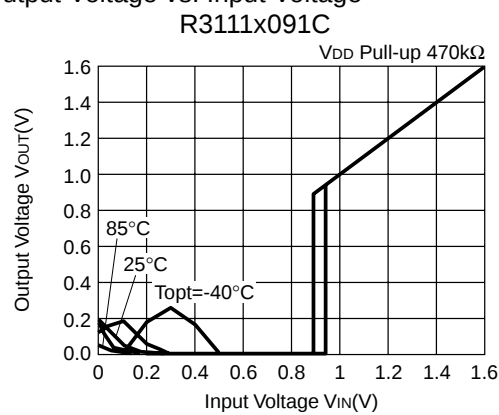


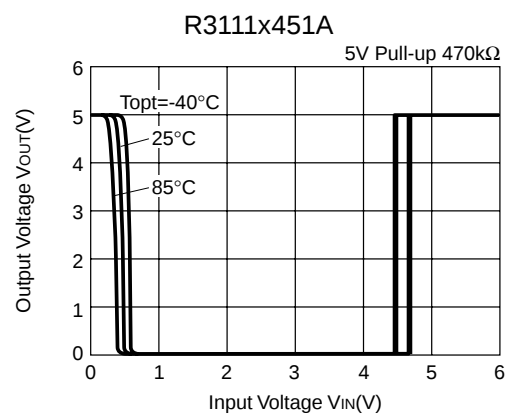
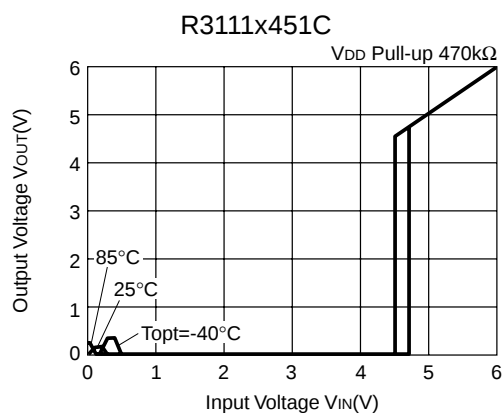
R3111x271C



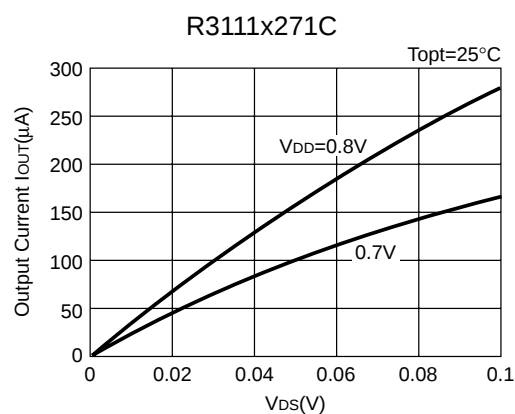
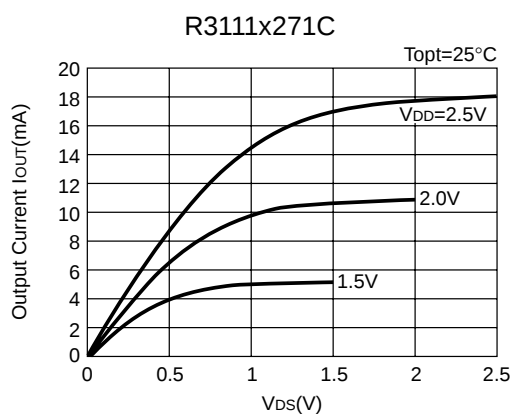
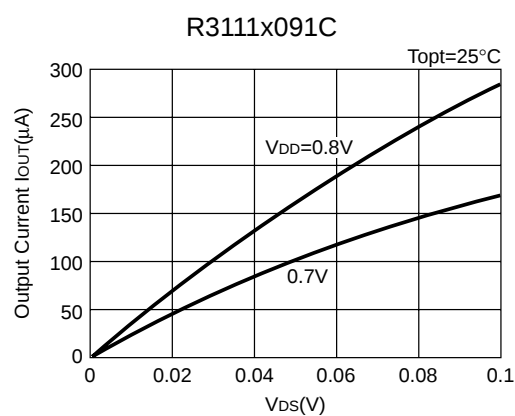
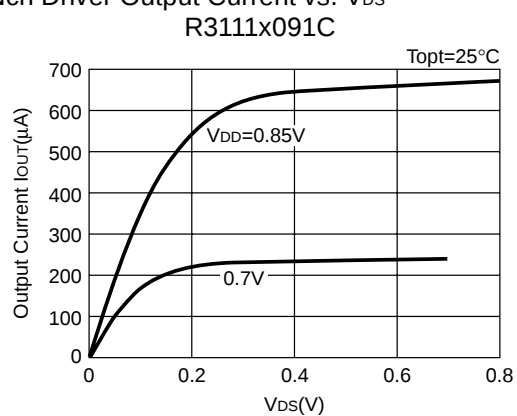


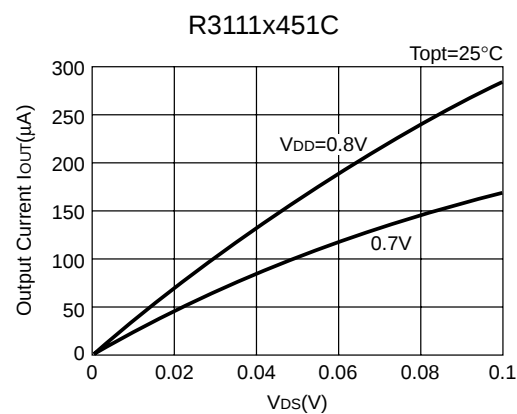
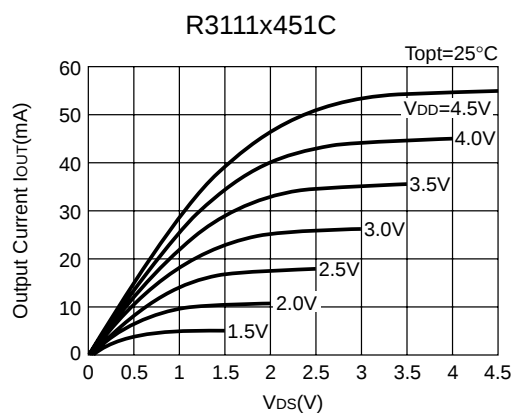
3) Output Voltage vs. Input Voltage



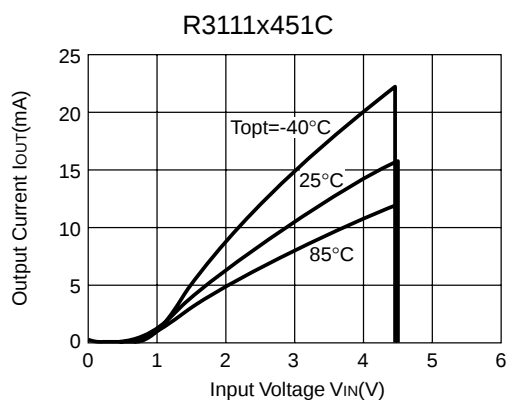
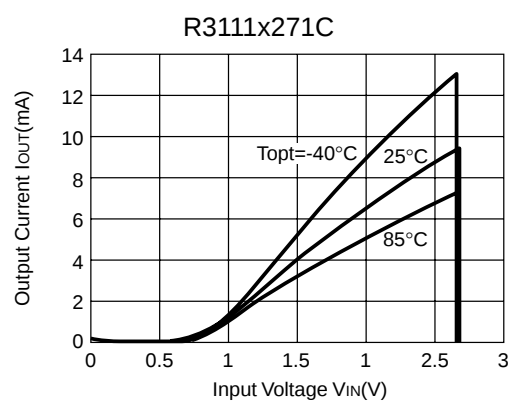
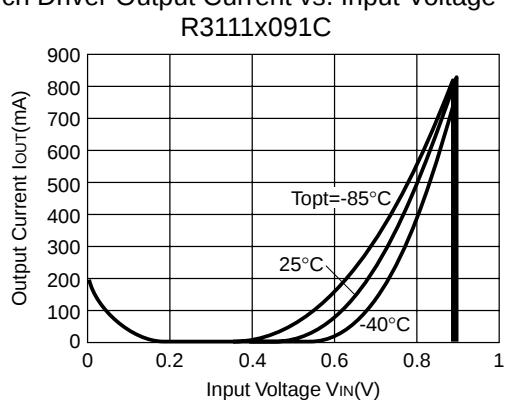


4) Nch Driver Output Current vs. V_{DS}

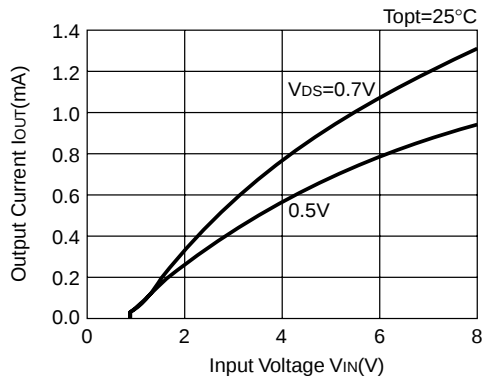




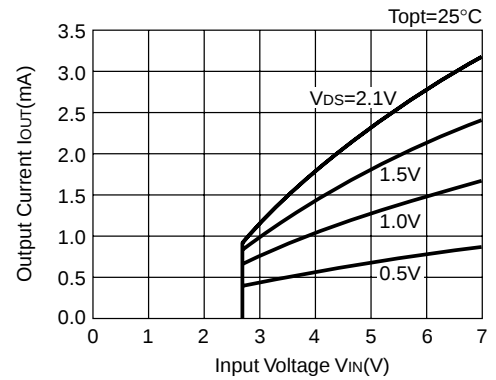
5) Nch Driver Output Current vs. Input Voltage



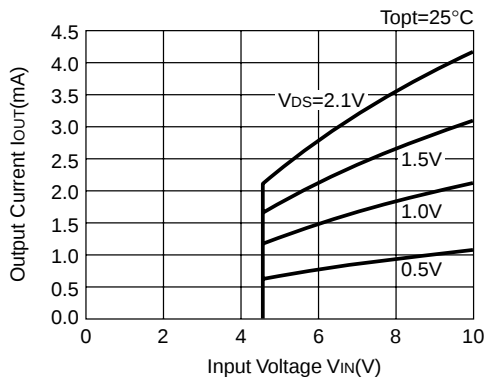
6) Pch Driver Output Current vs. Input Voltage
R3111x091C



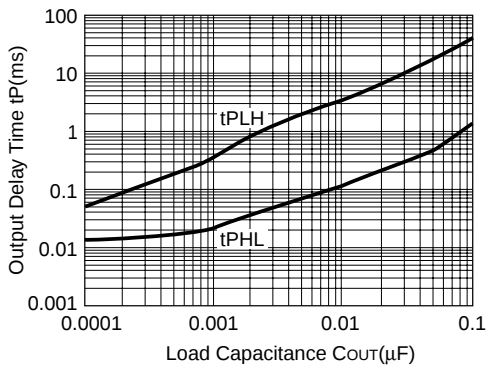
R3111x271C



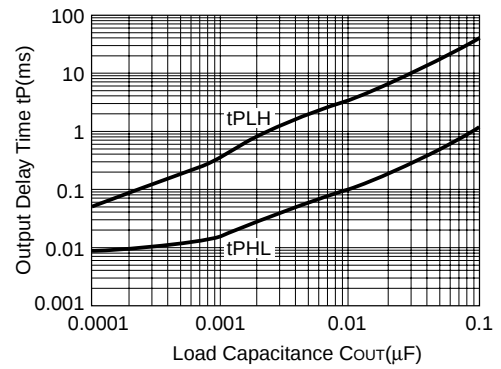
R3111x451C

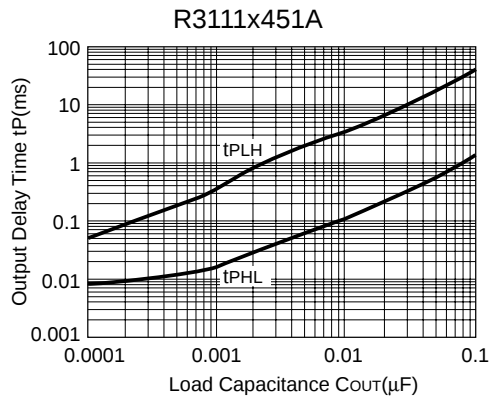


7) Output Delay Time vs. Load Capacitance
R3111x091A

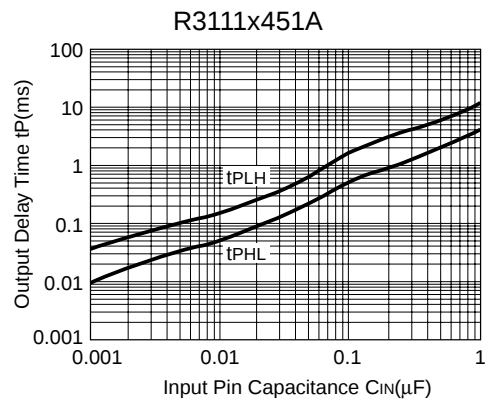
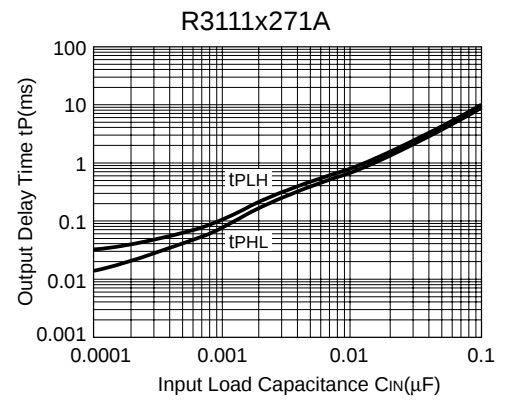
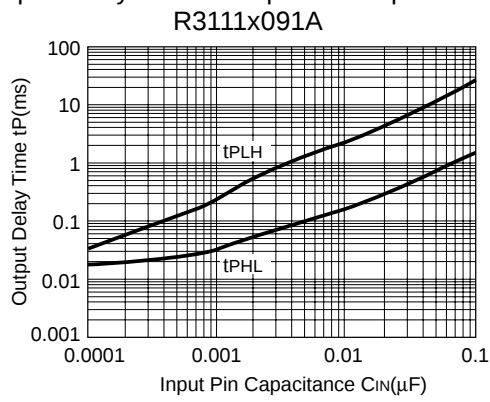


R3111x271A

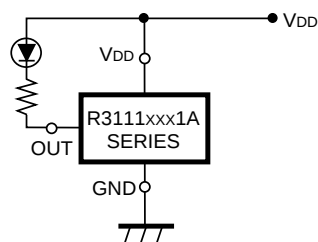




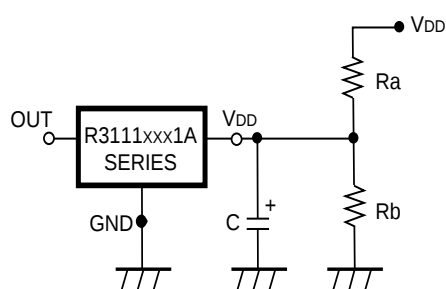
8) Output Delay Time vs. Input Pin Capacitance



- Voltage level Indicator Circuit (lighted when the power runs out)
(Nch Open Drain Output)



- Detector Threshold Adjustable Circuit
(Nch Open Drain Type Output)

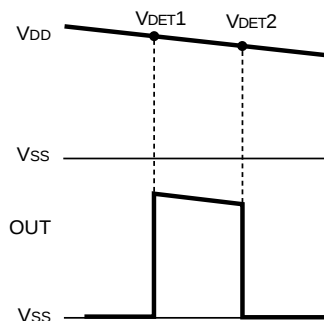
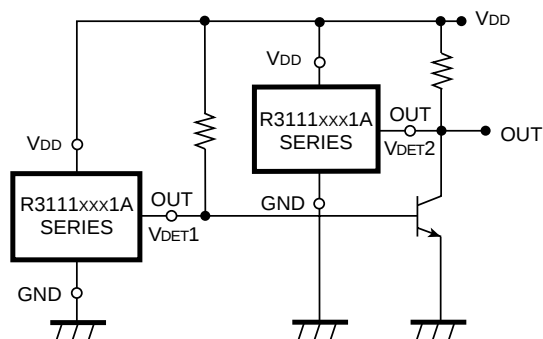


Adjusted Detector Threshold
 $= (-V_{DET}) * (Ra + Rb) / Rb$

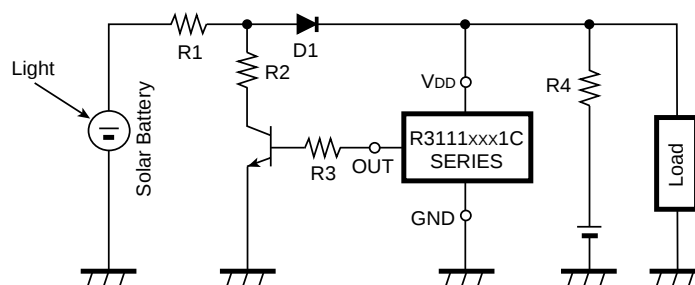
Hysteresis Voltage
 $= (V_{HYS}) * (Ra + Rb) / Rb$

*) If the value of Ra is set excessively large, voltage drop may occur caused by the supply current of IC itself, and detector threshold may vary.

- Window Comparator Circuit
(Nch Open Drain Output)



- Over-charge Preventing Circuit



TECHNICAL NOTES

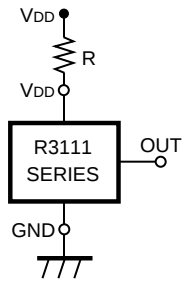


Figure 9

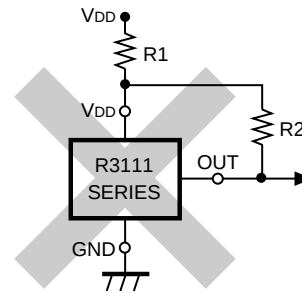


Figure 10

1. In Figure 9, When R3111xxx1C is used, and if an impedance is connected in between Voltage Supplier and the VDD Pin of R3111xxx1C Series, the operation might be unstable by through-type current at detection. When R3111xxx1A is used in Figure 9, if the value of R is set excessively large, voltage drop may occur caused by supply current of IC itself and Detector threshold may vary.
2. Wiring as shown in Figure 10 may cause the oscillation in both output types of R3111 Series.